N-channel TrenchMOS standard level FET Rev. 02 — 3 January 2008

Product data sheet

#### **Product profile** 1.

### 1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using NXP General-Purpose Automotive (GPA) TrenchMOS technology specifically optimized for linear operation. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

#### 1.2 Features

- 175 °C rated
- Stable operation in linear mode

### 1.3 Applications

- 12 V and 24 V loads
- DC linear motor control

- Q101 compliant
- TrenchMOS technology
- Automotive systems
- Repetitive clamped inductive switching

#### 1.4 Quick reference data

Table 1.	Quick reference						
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I <sub>D</sub>	drain current	$V_{GS} = 10 \text{ V}; T_{mb} = 25 \text{ °C};$ see <u>Figure 1</u> and <u>4</u>	[1]	-	-	75	A
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>		-	-	300	W
Avalanch	e ruggedness						
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$\begin{array}{l} I_{D} = 75 \text{ A}; \ V_{sup} \leq 55 \text{ V}; \\ R_{GS} = 50 \ \Omega; \ V_{GS} = 10 \text{ V}; \\ T_{j(init)} = 25 \ ^{\circ}\text{C}; \ unclamped \\ inductive \ load \end{array}$		-	-	1.1	J
Static cha	aracteristics						
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS}$ = 10 V; $I_D$ = 25 A; $T_j$ = 25 °C; see <u>Figure 12</u> and <u>13</u>		-	8.5	10	mΩ

[1] Continuous current is limited by package.



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## 2. Pinning information

Table 2.	Pinning			
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate	mb	D
2	D	drain		
3	S	source		G_(IET)
mb	D	mounting base; connected to drain		mbb076 S

SOT78 (TO-220AB)

## 3. Ordering information

#### Table 3.Ordering information

Type number	Package		
	Name	Description	Version
BUK7510-55AL	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78

## 4. Limiting values

#### Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Мах	Unit
V <sub>DS</sub>	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$	-	55	V
V <sub>DGR</sub>	drain-gate voltage	$R_{GS}$ = 20 k $\Omega$	-	55	V
$V_{GS}$	gate-source voltage		-20	20	V
I <sub>D</sub>	drain current	$T_{mb}$ = 25 °C; $V_{GS}$ = 10 V; see <u>Figure 1</u> and <u>4</u>	<u>[1][2]</u> _	122	А
		$T_{mb}$ = 25 °C; $V_{GS}$ = 10 V; see <u>Figure 1</u> and <u>4</u>	<u>[3]</u>	75	А
		$T_{mb}$ = 100 °C; $V_{GS}$ = 10 V; see <u>Figure 1</u>	<u>[3]</u>	75	А
I <sub>DM</sub>	peak drain current	$T_{mb}$ = 25 °C; $t_p \leq$ 10 $\mu s;$ pulsed; see Figure 4	-	490	А
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>	-	300	W
T <sub>stg</sub>	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
Avalancl	he ruggedness				
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$\begin{array}{l} I_D = 75 \; A; \; V_{sup} \leq 55 \; V; \; R_{GS} = 50 \; \Omega; \\ V_{GS} = 10 \; V; \; T_{j(init)} = 25 \; ^\circ C; \; unclamped \\ inductive \; load \end{array}$	-	1.1	J
E <sub>DS(AL)R</sub>	repetitive drain-source avalanche energy	see <u>Figure 3</u>	<u>[4][5]</u> [6]	-	J

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#### Table 4. Limiting values ... continued

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol Parameter		Conditions	Min	Max	Unit
Sourc	ce-drain diode				
$I_S$	source current	T <sub>mb</sub> = 25 °C	<u>[1][2]</u>	122	А
		T <sub>mb</sub> = 25 °C	<u>[3]</u>	75	А
I <sub>SM</sub>	peak source current	$t_p \le 10 \ \mu s$ ; pulsed; $T_{mb}$ = 25 °C	-	490	А

[1] Current is limited by power dissipation chip rating.

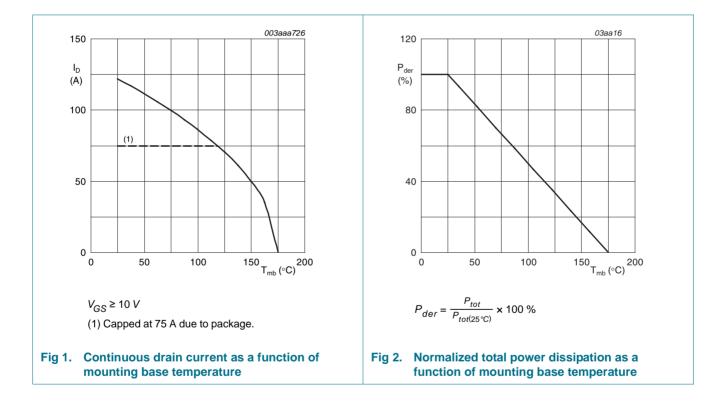
[2] Refer to document 9397 750 12572 for further information.

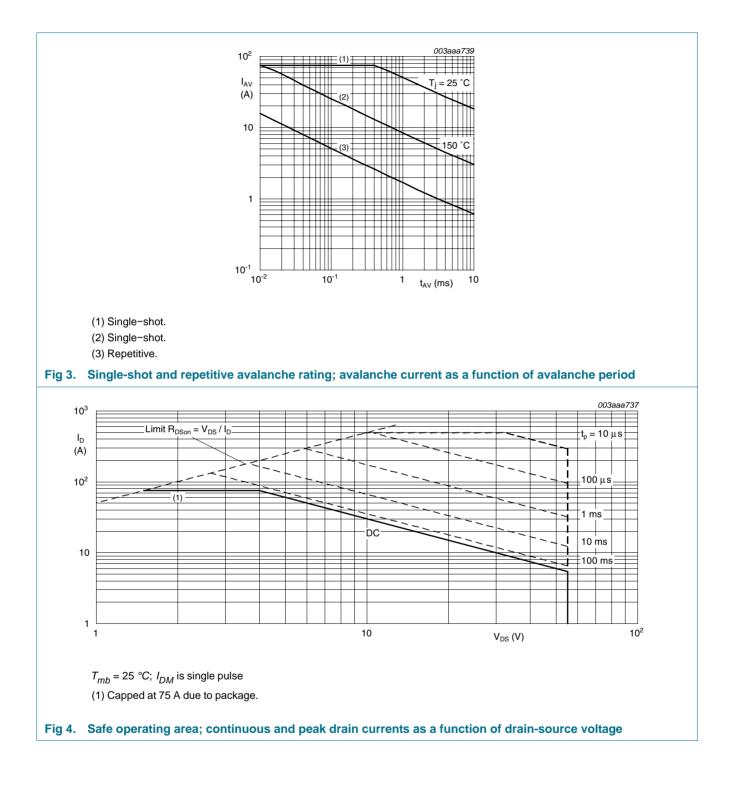
[3] Continuous current is limited by package.

[4] Single-shot avalanche rating limited by maximum junction temperature of 175 °C.

[5] Repetitive avalanche rating limited by average junction temperature of 170 °C.

[6] Refer to AN10273 for further information.

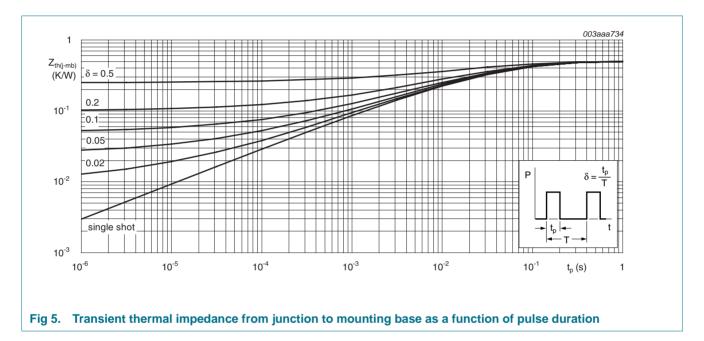




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### 5. Thermal characteristics

Table 5.	Thermal characteristic	cs				
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	vertical in still air	-	60	-	K/W
R <sub>th(j-mb)</sub>	thermal resistance from junction to mounting base	see <u>Figure 5</u>	-	0.25	0.5	K/W



### 6. Characteristics

#### Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V;$ $T_j = -55 \ ^{\circ}C$	50	-	-	V
		$I_D = 250 \ \mu\text{A}; \ V_{GS} = 0 \ \text{V}; \\ T_j = 25 \ ^{\circ}\text{C}$	55	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see <u>Figure 10</u> and <u>11</u>	2	3	4	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS};$ $T_j = -55 \text{ °C}; \text{ see } Figure 10 \text{ and } 11$	-	-	4.4	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS};$ $T_j = 175 \text{ °C}; \text{ see } \frac{\text{Figure } 10}{11} \text{ and } \frac{11}{1}$	1	-	-	V

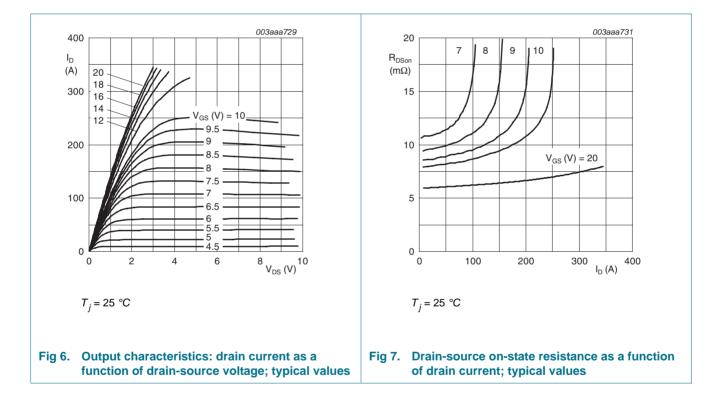
Table 6.	Characteristics continu		<b>P4</b> !	<b>T</b>	N4	11.14
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V};$ $T_j = 175 \text{ °C}$	-	-	500	μΑ
		$V_{DS}$ = 55 V; $V_{GS}$ = 0 V; $T_j$ = 25 °C	-	0.05	10	μA
I <sub>GSS</sub>	gate leakage current	$V_{DS} = 0 V; V_{GS} = +20 V;$ $T_j = 25 °C$	-	2	100	nA
		$V_{DS} = 0 V; V_{GS} = -20 V;$ $T_j = 25 °C$	-	2	100	nA
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A};$ T <sub>j</sub> = 175 °C; see <u>Figure 12</u> and <u>13</u>	-	-	20	mΩ
		$V_{GS}$ = 10 V; $I_D$ = 25 A; $T_j$ = 25 °C; see <u>Figure 12</u> and <u>13</u>	-	8.5	10	mΩ
Source-dr	ain diode					
V <sub>SD</sub>	source-drain voltage	I <sub>S</sub> = 25 A; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C; see <u>Figure 16</u>	-	0.85	1.2	V
t <sub>rr</sub>	reverse recovery time	$    I_S = 20 \text{ A};  dI_S/dt = -100  A/\mu\text{s}; \\     V_{GS} = 0  V;  V_{DS} = 30  V;  T_j = 25 ^\circ\text{C} $	-	73	-	ns
Qr	recovered charge	$    I_S = 20 \text{ A};  \text{dI}_S/\text{dt} = -100  \text{A}/\mu\text{s}; \\        V_{GS} = 0  \text{V};  \text{V}_{DS} = 30  \text{V};  \text{T}_\text{j} = 25 ^\circ\text{C} $	-	430	-	nC
Dynamic o	characteristics					
Q <sub>G(tot)</sub>	total gate charge	I <sub>D</sub> = 25 A; V <sub>DS</sub> = 44 V; V <sub>GS</sub> = 10 V; T <sub>j</sub> = 25 °C; see <u>Figure 14</u>	-	124	-	nC
Q <sub>GS</sub>	gate-source charge	$I_D = 25 \text{ A}; V_{DS} = 44 \text{ V};$ $V_{GS} = 10 \text{ V}; T_j = 25 \text{ °C};$ see Figure 14	-	22	-	nC
Q <sub>GD</sub>	gate-drain charge	I <sub>D</sub> = 25 A; V <sub>DS</sub> = 44 V; V <sub>GS</sub> = 10 V; T <sub>j</sub> = 25 °C; see <u>Figure 14</u>	-	50	-	nC
V <sub>GS(pl)</sub>	gate-source plateau voltage	$I_D = 25 \text{ A}; V_{DS} = 44 \text{ V}; T_j = 25 \text{ °C};$ see Figure 14	-	5	-	V
C <sub>iss</sub>	input capacitance	V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 25 V; f = 1 MHz; T <sub>j</sub> = 25 °C; see <u>Figure 15</u>	-	4710	6280	pF
C <sub>oss</sub>	output capacitance	V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 25 V; f = 1 MHz; T <sub>j</sub> = 25 °C; see <u>Figure 15</u>	-	980	1180	pF
C <sub>rss</sub>	reverse transfer capacitance	V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 25 V; f = 1 MHz; T <sub>j</sub> = 25 °C; see <u>Figure 15</u>	-	560	770	pF
t <sub>d(on)</sub>	turn-on delay time		-	33	-	ns
t <sub>r</sub>	rise time		-	117	-	ns

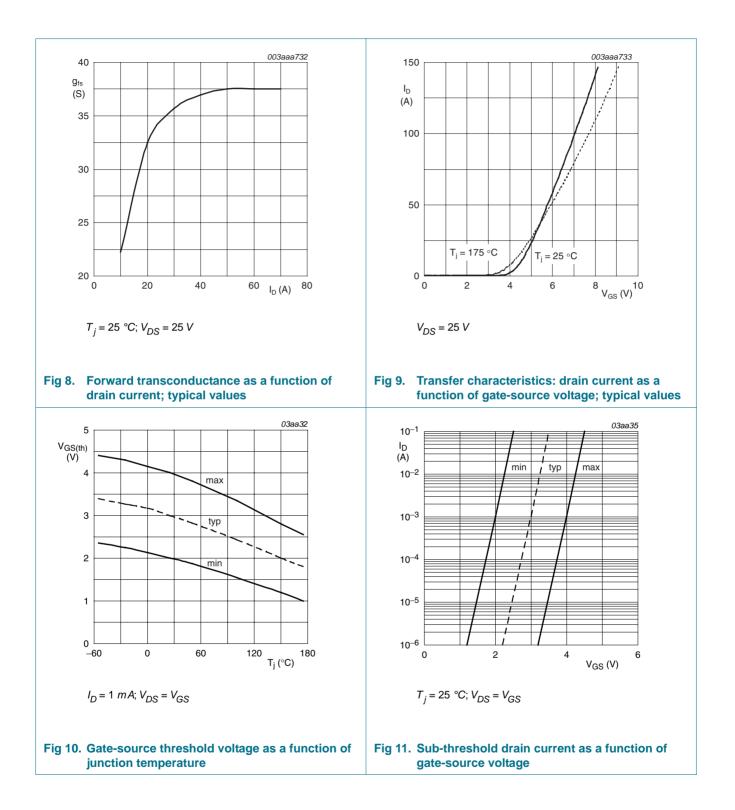
Characteristics ... continued

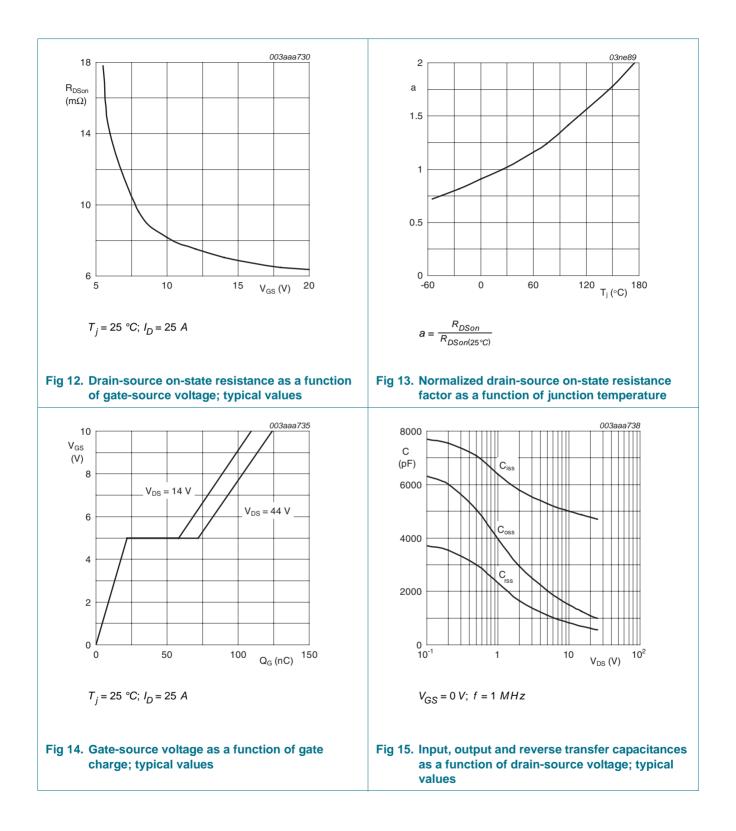
Table 6.

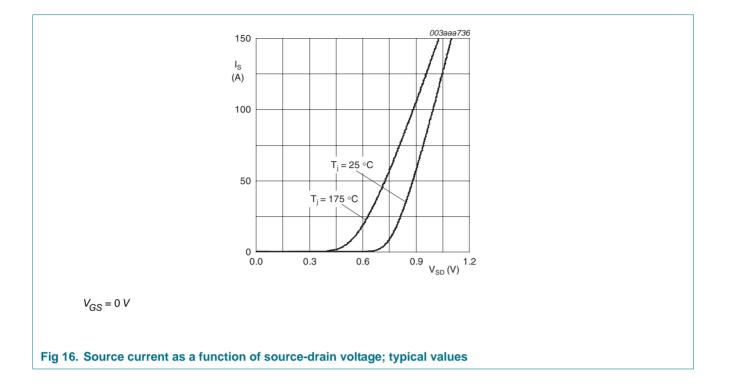
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Symbol	Parameter	Conditions	Min	Тур	Max	Unit
t <sub>d(off)</sub>	turn-off delay time		-	132	-	ns
t <sub>f</sub>	fall time		-	95	-	ns
L <sub>D</sub>	internal drain inductance	from contact screw on package to center of die; $T_j = 25 \ ^{\circ}C$	-	3.5	-	nH
		from drain lead 6 mm from package to center of die; T <sub>j</sub> = 25 °C	-	4.5	-	nH
L <sub>S</sub>	internal source inductance	from source lead to source bond pad; T <sub>j</sub> = 25 °C	-	7.5	-	nH









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### 7. Package outline

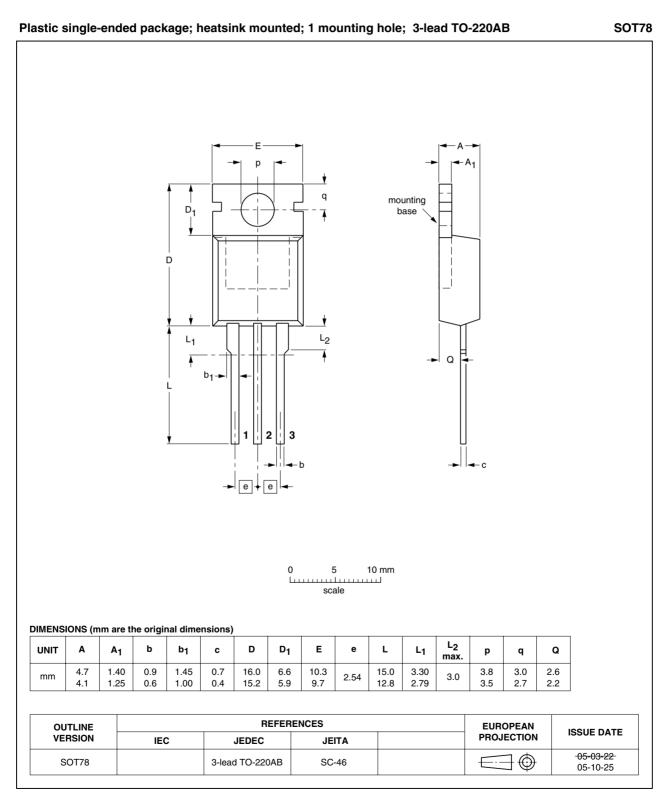


Fig 17. Package outline SOT78 (TO-220AB)

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## 8. Revision history

Table 7. Revision his	tory				
Document ID	Release date	Data sheet status	Change notice	Supersedes	
BUK7510_55AL_2	20080103	Product data sheet	-	BUK75_7610_55AL_1	
Modifications:	<ul> <li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> </ul>				
	<ul> <li>Legal texts</li> </ul>	have been adapted to the	new company name whe	ere appropriate.	
	<ul> <li>Typical ther</li> </ul>	mal resistance from junction	on to mounting base figur	re added in <u>Table 5</u> .	
BUK75_7610_55AL_1	20050331	Product data sheet	-	-	

## 9. Legal information

### 9.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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